


<b>Search Notes</b>  	<b>Application/Control No.</b>  10644604	<b>Applicant(s)/Patent Under Reexamination</b>  WALSH ET AL.
	<b>Examiner</b>  Anthony Weier	<b>Art Unit</b>  1794

SEARCHED			
Class	Subclass	Date	Examiner
updated	previous search	6/4/08	AW
updated	previous search	1/29/09	AW

SEARCH NOTES		
Search Notes	Date	Examiner

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner

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